

Notice of References Cited	Application/Control No. 10/669,081	Applicant(s)/Patent Under Reexamination LAI ET AL.	
	Examiner George C. Eckert II	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,973,337	10-1999	Knapp et al.	257/99
	B	US-6,143,588	11-2000	Glenn, Thomas P.	438/116
	C	US-6,348,682 B1	02-2002	Lee, See T.	250/214A
	D	US-6,483,101 B1	11-2002	Webster, Steven	250/216
	E	US-6,521,476 B2	02-2003	Kubota, Munechika	438/39
	F	US-2003/0089958 A1	05-2003	Gutierrez-Aitken et al.	257/458
	G	US-6,586,721 B2	07-2003	Estevez-Garcia, Jaime	250/221
	H	US-6,614,103 B1	09-2003	Durocher et al.	257/678
	I	US-6,633,421 B2	10-2003	Trezza, John	438/24
	J	US-6,686,580 B1	02-2004	Glenn et al.	250/208.1
	K	US-6,737,720 B2	05-2004	Ho et al.	257/433
	L	US-2005/0051859 A1	03-2005	Hoffman, Paul Robert	257/434
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63066964 A	03-1988	Japan	YABE, HISAO	H01L 27/14
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.